

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/770,473	<b>Applicant(s)/Patent under Reexamination</b> HSU, HUL-CHUN
	<b>Examiner</b> David E. Bochna	<b>Art Unit</b> 3679

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
285	382	1/23/2007	DB